PATENT ABSTRACTS OF JAPAN

(11) Publication number:

10-241388

(43)Date of publication of application: 11.09.1998

(51)Int.CI.

G11C 16/06 G11C 16/02

H02M 3/00 H02M 3/07

(21)Application number: 09-099362

(71)Applicant: SONY CORP

(22)Date of filing:

16.04.1997

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(30)Priority

Priority number: 08358022

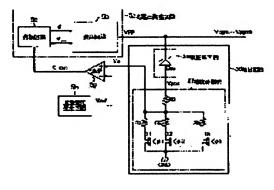
Priority date: 29.12.1996

Priority country: JP

(54) VOLTAGE SUPPLY CIRCUIT AND SEMICONDUCTOR NONVOLATILE STORAGE DEVICE

(57)Abstract:

PROBLEM TO BE SOLVED: To generate a program voltage and to efficiently execute a data program by controlling a high voltage generating circuit with a boosting control signal obtained by a comparison result between a voltage selectively dropped from a boosted voltage of the high voltage generating circuit through a voltage dropping means and a resistance dividing means. SOLUTION: The high voltage VPP of the high voltage generating circuit 5a is dropped by a prescribed voltage by a voltage dropping part 5e with a Zener diode Dze to output a dropped voltage VPPd. This dropped voltage VPPd is voltage-divided by a resistance dividing circuit 5f with a resistor R0 and resistor elements R1-Rk connected with transfer gates T1-Tk by control signals ϕ1-&phiv:k to output a divided voltage Va. An oscillation circuit 5c is controlled by the boosting control signal C-out outputted by a comparator circuit 5g comparing the divided voltage Va with the reference voltage Vref. By this method, gradually increasing program word line voltages Vpgm1-k are outputted, and increase of an occupied area of the resistor elements can be avoided.



LEGAL STATUS

[Date of request for examination]

[Date of sending the examiner's decision of rejection]

[Kind of final disposal of application other than the examiner's decision of rejection or application converted registration]

[Date of final disposal for application]

[Patent number]

[Date of registration]

[Number of appeal against examiner's decision of rejection]

[Date of requesting appeal against examiner's decision of rejection]
[Date of extinction of right]

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